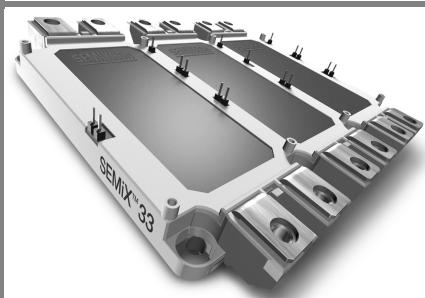


# SEMiX 253GD126HDc



**SEMIX™ 33c**

## Trench IGBT Modules

### SEMIX 253GD126HDC

#### Target Data

#### Features

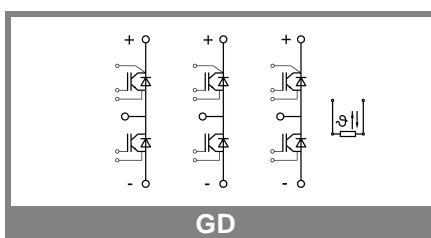
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability

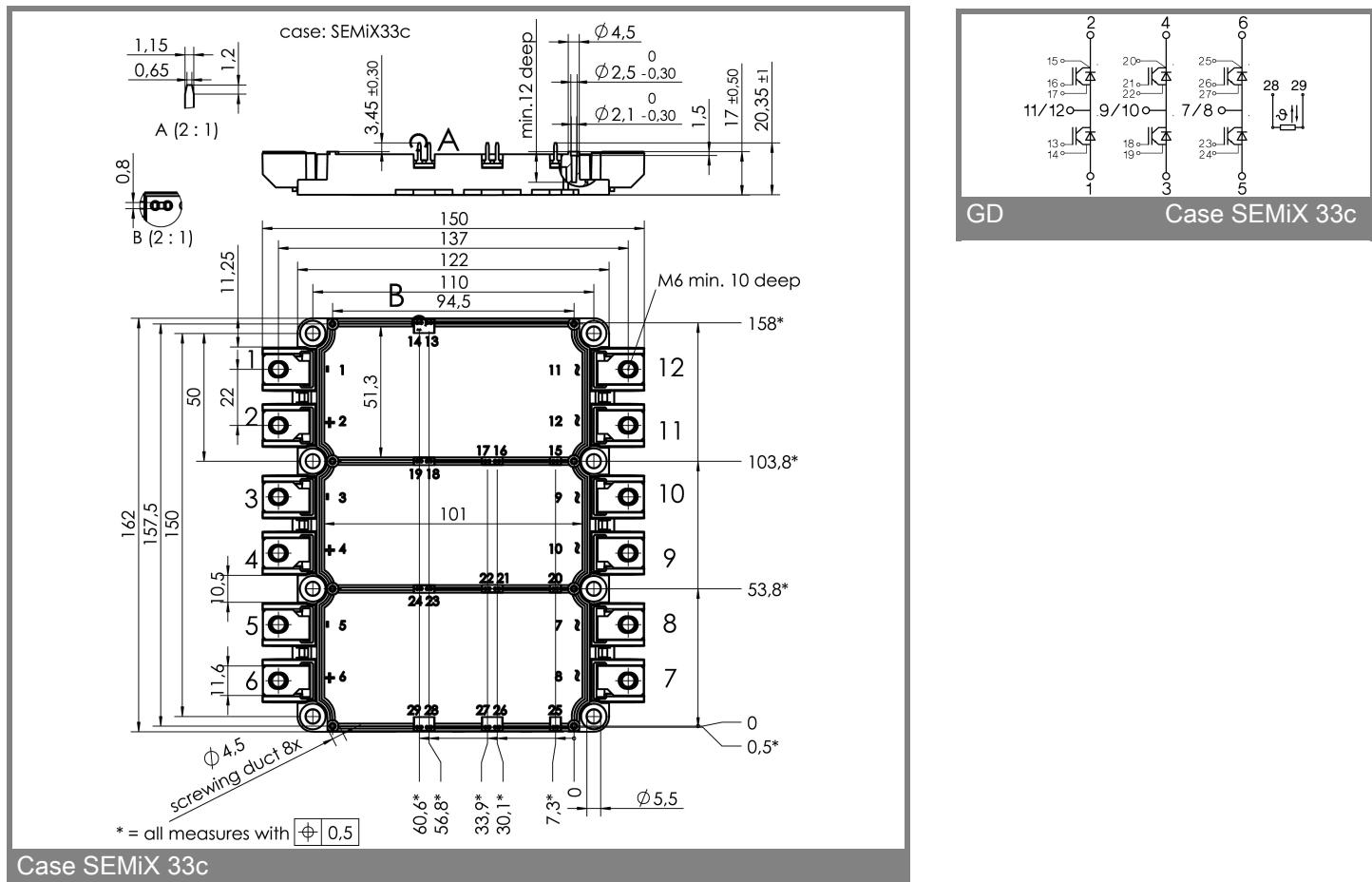
#### Typical Applications

- AC inverter driver
- UPS
- Electronic welders

Absolute Maximum Ratings		$T_{case} = 25^\circ\text{C}$ , unless otherwise specified		
Symbol	Conditions	Values		Units
<b>IGBT</b>				
$V_{CES}$		1200		V
$I_C$	$T_c = 25 \text{ (80)}^\circ\text{C}$	250 (180)	A	
$I_{CRM}$	$T_c = 25 \text{ (80)}^\circ\text{C}, t_p = 1 \text{ ms}$	500 (360)	A	
$V_{GES}$		$\pm 20$	V	
$T_{vj} \text{ (T}_{stg}\text{)}$	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	°C	
$V_{isol}$	AC, 1 min.	4000	V	
<b>Inverse diode</b>				
$I_F = - I_C$	$T_c = 25 \text{ (80)}^\circ\text{C}$	190 (130)	A	
$I_{FRM}$	$T_c = 25 \text{ (80)}^\circ\text{C}, t_p = 1 \text{ ms}$	500 (360)	A	
$I_{FSM}$	$t_p = 10 \text{ ms}; \sin.; T_j = 25^\circ\text{C}$			A

Characteristics		$T_{case} = 25^\circ\text{C}$ , unless otherwise specified		
Symbol	Conditions	min.	typ.	max.
<b>IGBT</b>				
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 6 \text{ mA}$	5	5,8	6,5
$I_{CES}$	$V_{GE} = 0, V_{CE} = V_{CES}, T_j = 25 \text{ (125)}^\circ\text{C}$		1	mA
$V_{CE(TO)}$	$T_j = 25 \text{ (125)}^\circ\text{C}$		1 (0,9)	1,2 (1,1)
$r_{CE}$	$V_{GE} = 15 \text{ V}, T_j = 25 \text{ (125)}^\circ\text{C}$		4,3 (7,3)	mΩ
$V_{CE(sat)}$	$I_C = 150 \text{ A}, V_{GE} = 15 \text{ V}, T_j = 25 \text{ (125)}^\circ\text{C, chip level}$		1,7 (2)	V
$C_{ies}$	under following conditions		10,8	nF
$C_{oes}$	$V_{GE} = 0, V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}$		0,6	nF
$C_{res}$			0,5	nF
$L_{CE}$			20	nH
$R_{CC+EE'}$	resistance, terminal-chip, $T_c = 25 \text{ (125)}^\circ\text{C}$		0,8 (1,2)	mΩ
$t_{d(on)}/t_f$	$V_{CC} = 600 \text{ V}, I_C = 150 \text{ A}$			ns
$t_{d(off)}/t_f$	$V_{GE} = \pm 15 \text{ V}$			ns
$E_{on} (E_{off})$	$E_{on} = E_{off} = 10 \mu\text{J}, T_j = 125^\circ\text{C}$		17 (21)	mJ
<b>Inverse diode</b>				
$V_F = V_{EC}$	$I_F = 150 \text{ A}; V_{GE} = 0 \text{ V}; T_j = 25 \text{ (125)}^\circ\text{C, chip level}$		1,6 (1,6)	V
$V_{(TO)}$	$T_j = 25 \text{ (125)}^\circ\text{C}$		1 (0,8)	V
$r_T$	$T_j = 25 \text{ (125)}^\circ\text{C}$		4 (5,3)	mΩ
$I_{RRM}$	$I_F = 150 \text{ A}; T_j = 25 \text{ (125)}^\circ\text{C}$			A
$Q_{rr}$	$dI/dt = \text{A}/\mu\text{s}$			μC
$E_{rr}$	$V_{GE} = 0 \text{ V}$			mJ
<b>Thermal characteristics</b>				
$R_{th(j-c)}$	per IGBT		0,14	K/W
$R_{th(j-c)D}$	per Inverse Diode		0,33	K/W
$R_{th(j-c)FD}$	per FWD			K/W
$R_{th(c-s)}$	per module		0,014	K/W
<b>Temperature sensor</b>				
$R_{25}$	$T_c = 25^\circ\text{C}$		5 ± 5%	kΩ
$B_{25/85}$	$R_2 = R_1 \exp[B(1/T_2 - 1/T_1)] ; T[\text{K}]; B$		3420	K
<b>Mechanical data</b>				
$M_s/M_t$	to heatsink (M5) / for terminals (M6)	3/2,5	5 / 5	Nm
w		882		g





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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